

## 600V 0.08Ω Super Junction Power MOSFET

**Description**

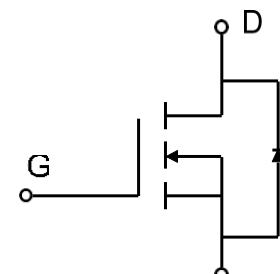
WMOS™ C4 is Wayon's 4<sup>th</sup> generation super junction MOSFET family that is utilizing charge balance technology for extremely low on-resistance and low gate charge performance. WMOS™ C4 is suitable for applications which require superior power density and outstanding efficiency.



TO-220F

**Features**

- $V_{DS} = 650V @ T_{j,max}$
- Typ.  $R_{DS(on)} = 0.08\Omega$
- 100% UIS tested
- Pb-free plating, Halogen free

**Applications**

LED Lighting, Charger, Adapter, PC, LCD TV, Server

**Absolute Maximum Ratings**

Parameter	Symbol	WMK/WMM/WMN/WMJ	WML	Unit
Drain-source voltage	$V_{DSS}$	600		V
Continuous drain current <sup>1)</sup> ( $T_C = 25^\circ C$ )	$I_D$	36		A
( $T_C = 100^\circ C$ )		20		A
Pulsed drain current <sup>2)</sup>	$I_{DM}$	100		A
Gate-source voltage	$V_{GS}$	$\pm 30$		V
Avalanche energy, single pulse <sup>3)</sup>	$E_{AS}$	550		mJ
Avalanche energy, repetitive <sup>2)</sup>	$E_{AR}$	0.8		mJ
Avalanche current, repetitive <sup>2)</sup>	$I_{AR}$	4		A
Power dissipation ( $T_C = 25^\circ C$ )	$P_D$	277	34	W
- Derate above $25^\circ C$		2.22	0.27	$W/C$
Operating and storage temperature range	$T_j, T_{stg}$	-55 to +150		°C
Continuous diode forward current	$I_S$	36		A
Diode pulse current	$I_{S,pulse}$	100		A

**Thermal Characteristics**

Parameter	Symbol	WMK/WMM/WMN/WMJ	WML	Unit
Thermal resistance, junction-to-case	$R_{\theta JC}$	0.45	3.6	°C/W
Thermal resistance, junction-to-ambient	$R_{\theta A}$	62	80	°C/W

## Electrical Characteristics ( $T_c = 25^\circ\text{C}$ , unless otherwise noted)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
<b>Static characteristics</b>						
Drain-source breakdown voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}}=0 \text{ V}, I_{\text{D}}=1 \text{ mA}$	600	-	-	V
Gate threshold voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=0.25 \text{ mA}$	2	3	4	V
Drain cut-off current	$I_{\text{DSS}}$	$V_{\text{DS}}=600 \text{ V}, V_{\text{GS}}=0 \text{ V},$ $T_j = 25^\circ\text{C}$ $T_j = 125^\circ\text{C}$	-	-	1	$\mu\text{A}$
Gate leakage current, forward	$I_{\text{GSSF}}$	$V_{\text{GS}}=20 \text{ V}, V_{\text{DS}}=0 \text{ V}$	-	-	100	nA
Gate leakage current, reverse	$I_{\text{GSSR}}$	$V_{\text{GS}}=-20 \text{ V}, V_{\text{DS}}=0 \text{ V}$	-	-	-100	nA
Drain-source on-state resistance	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}}=10 \text{ V}, I_{\text{D}}=15 \text{ A}$ $T_j = 25^\circ\text{C}$	-	0.08	0.097	$\Omega$
<b>Dynamic characteristics</b>						
Input capacitance	$C_{\text{iss}}$	$V_{\text{DS}}=100 \text{ V}, V_{\text{GS}}=0 \text{ V},$ $f = 1 \text{ MHz}$	-	2250	-	pF
Output capacitance	$C_{\text{oss}}$		-	78	-	
Reverse transfer capacitance	$C_{\text{rss}}$		-	2.8	-	
Turn-on delay time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}}=300 \text{ V}, I_{\text{D}}=15 \text{ A}$ $R_G = 25 \Omega, V_{\text{GS}}=10 \text{ V}$	-	37	-	ns
Rise time	$t_r$		-	39	-	
Turn-off delay time	$t_{\text{d}(\text{off})}$		-	270	-	
Fall time	$t_f$		-	57	-	
<b>Gate charge characteristics</b>						
Gate to source charge	$Q_{\text{gs}}$	$V_{\text{DD}}=480 \text{ V}, I_{\text{D}}=15 \text{ A},$ $V_{\text{GS}}=0 \text{ to } 10 \text{ V}$	-	8.7	-	nC
Gate to drain charge	$Q_{\text{gd}}$		-	14.2	-	
Gate charge total	$Q_g$		-	46.0	-	
Gate plateau voltage	$V_{\text{plateau}}$		-	5.0	-	V
<b>Reverse diode characteristics</b>						
Diode forward voltage	$V_{\text{SD}}$	$V_{\text{GS}}=0 \text{ V}, I_{\text{F}}=15 \text{ A}$	-	-	1.2	V
Reverse recovery time	$t_{\text{rr}}$	$V_R=50 \text{ V}, I_{\text{F}}=15 \text{ A},$ $dI/dt=100 \text{ A}/\mu\text{s}$	-	261	-	ns
Reverse recovery charge	$Q_{\text{rr}}$		-	3.6	-	$\mu\text{C}$
Peak reverse recovery current	$I_{\text{rrm}}$		-	27.2	-	A

Notes:

1. Limited by  $T_{j\max}$ . Maximum duty cycle D=0.5.
2. Repetitive rating: pulse width limited by maximum junction temperature.
3.  $I_{AS}=4 \text{ A}, V_{DD}=50 \text{ V}, R_G=25 \Omega$ , starting  $T_j=25^\circ\text{C}$ .

## Typical Performance Characteristics

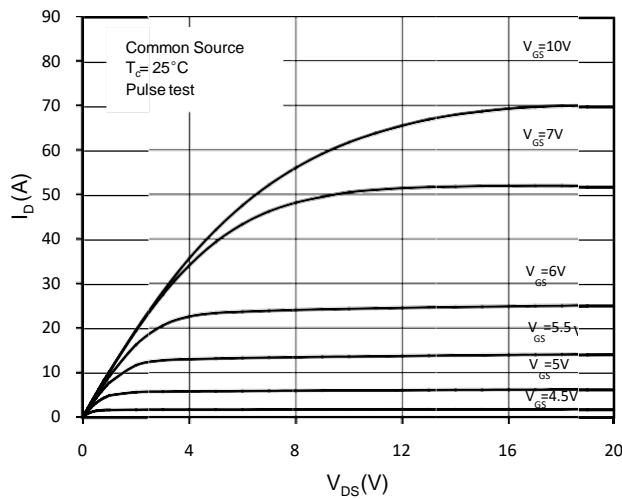


Figure 1. On-Region Characteristics

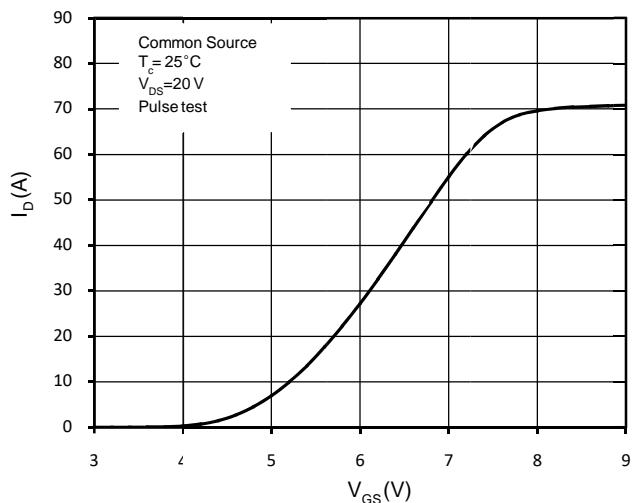


Figure 2. Transfer Characteristics

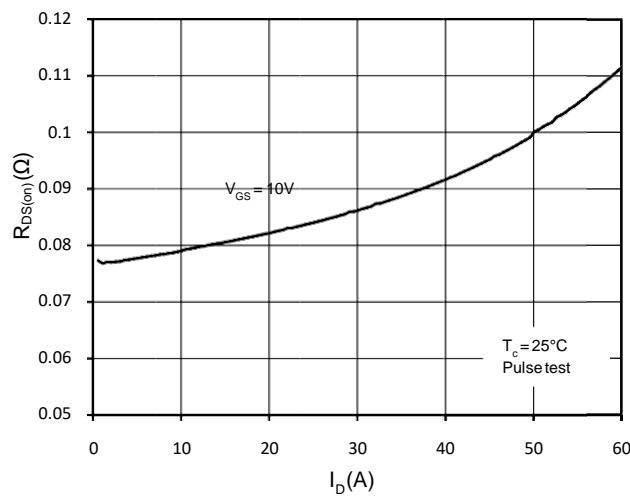


Figure 3. Static Drain-Source On Resistance

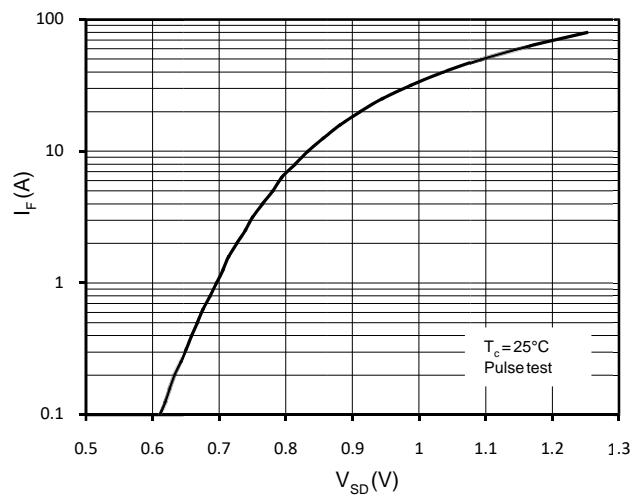


Figure 4. Body-Diode Forward Characteristics

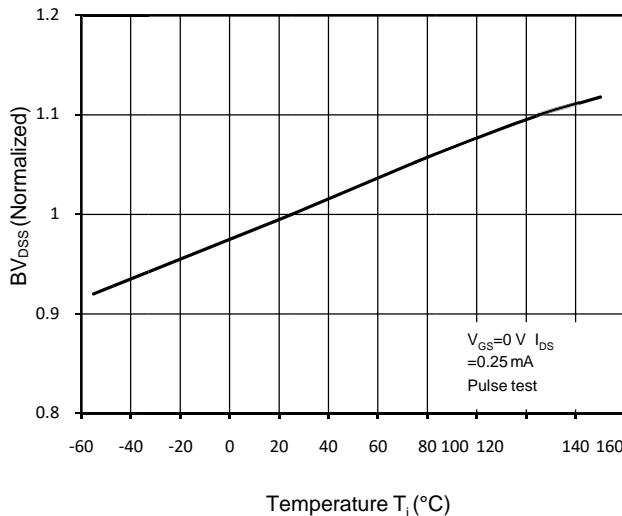


Figure 5. Normalized  $BV_{DSS}$  vs. Temperature

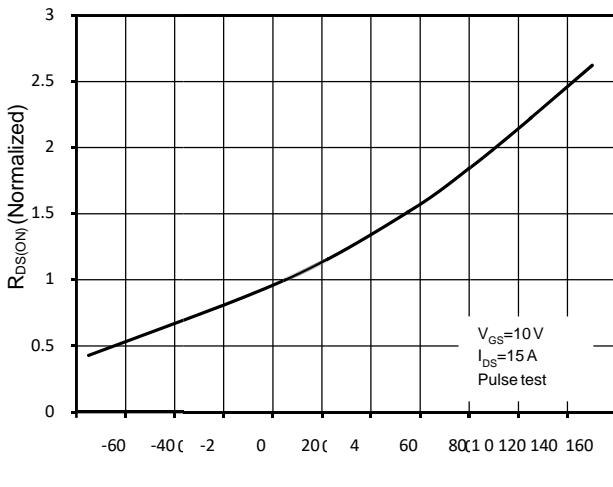
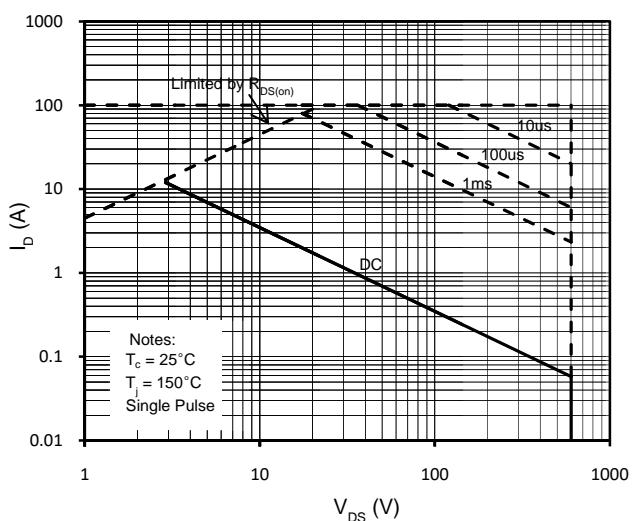
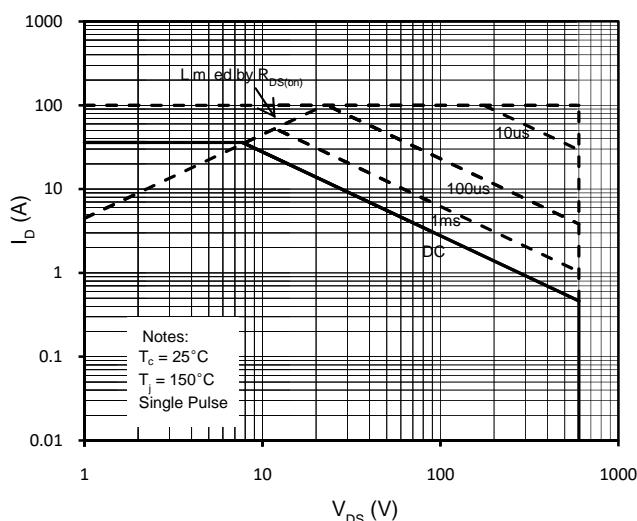
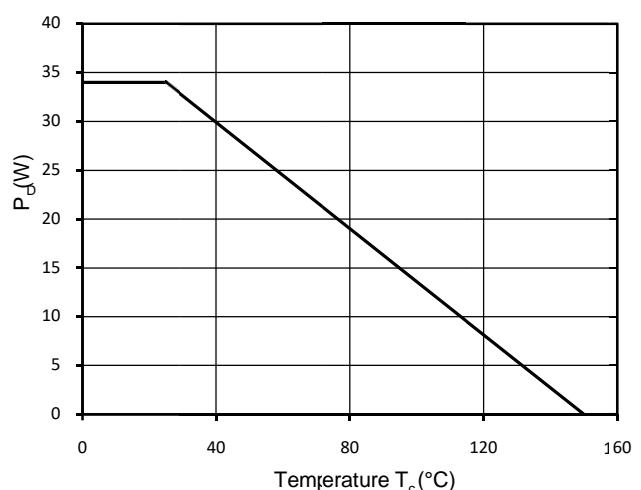
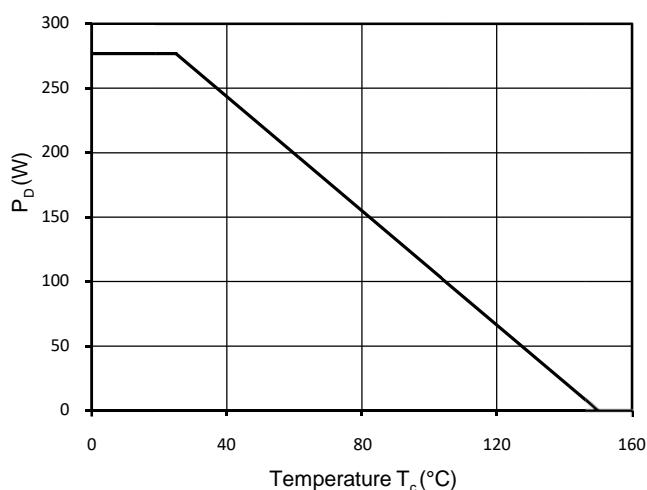
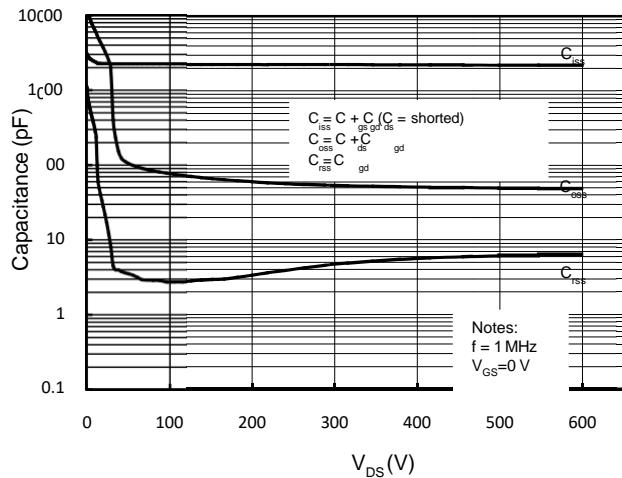
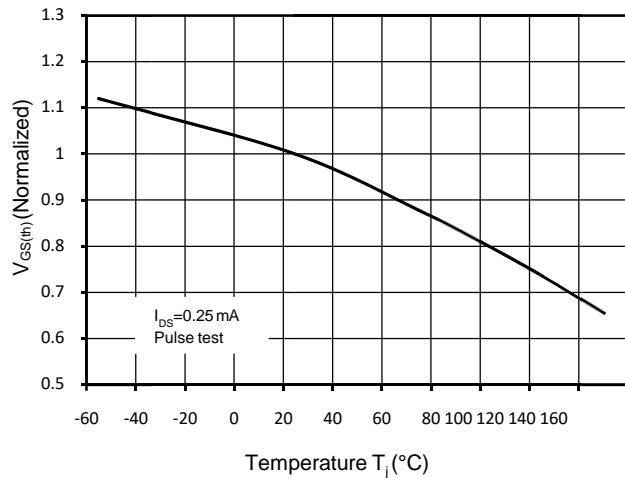


Figure 6. Normalized  $R_{DS(on)}$  vs. Temperature

## Typical Performance Characteristics(Con.)



## Typical Performance Characteristics(Con.)

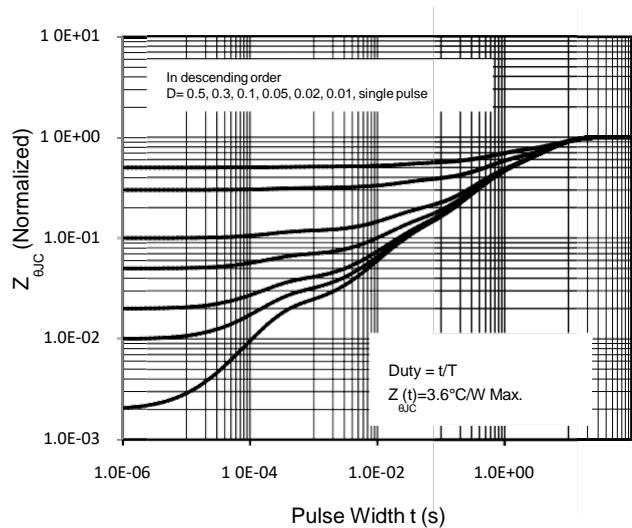


Figure 13. Transient Thermal Response Curve (TO-220F)

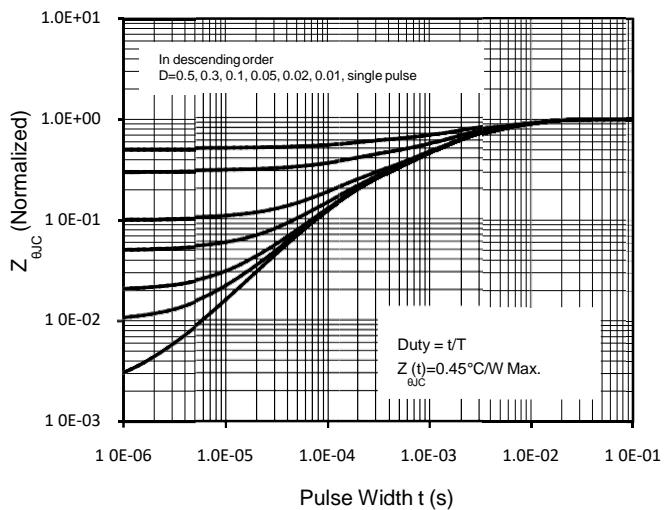


Figure 14. Transient Thermal Response Curve

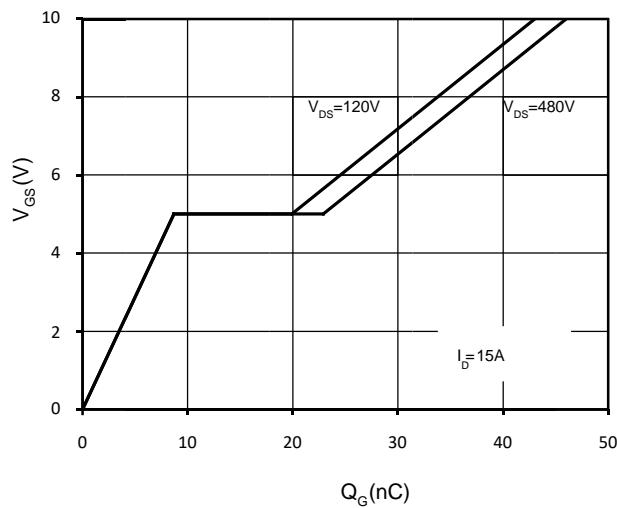
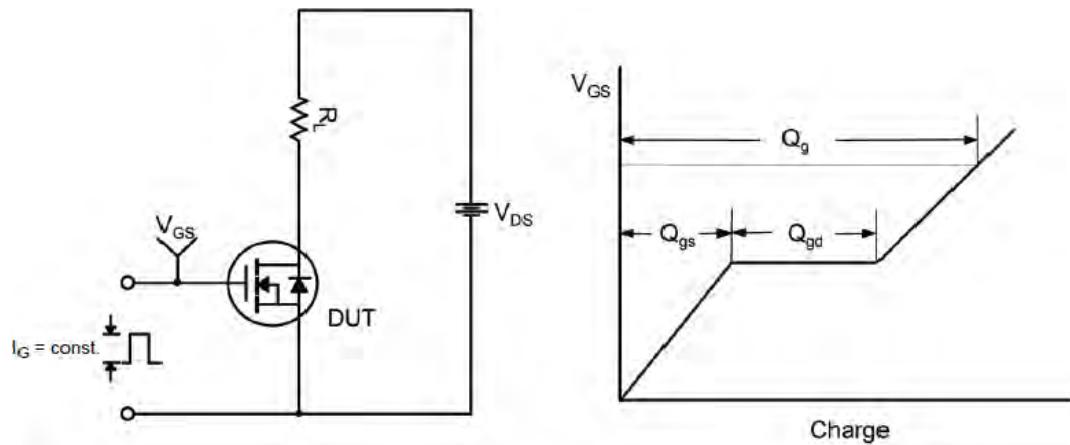
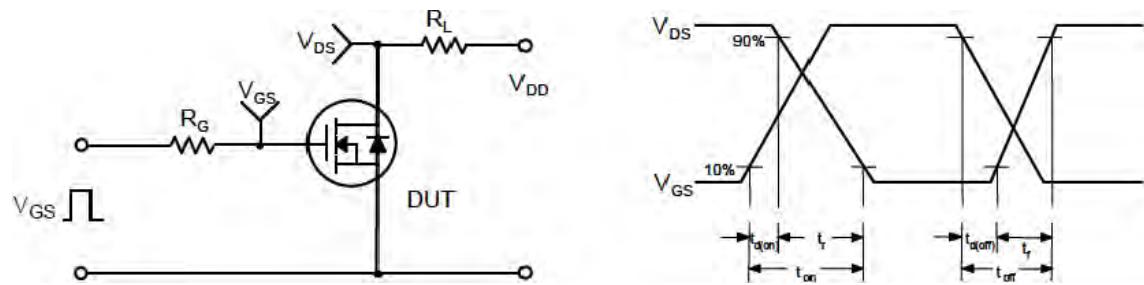


Figure 15. Gate Charge Characteristics

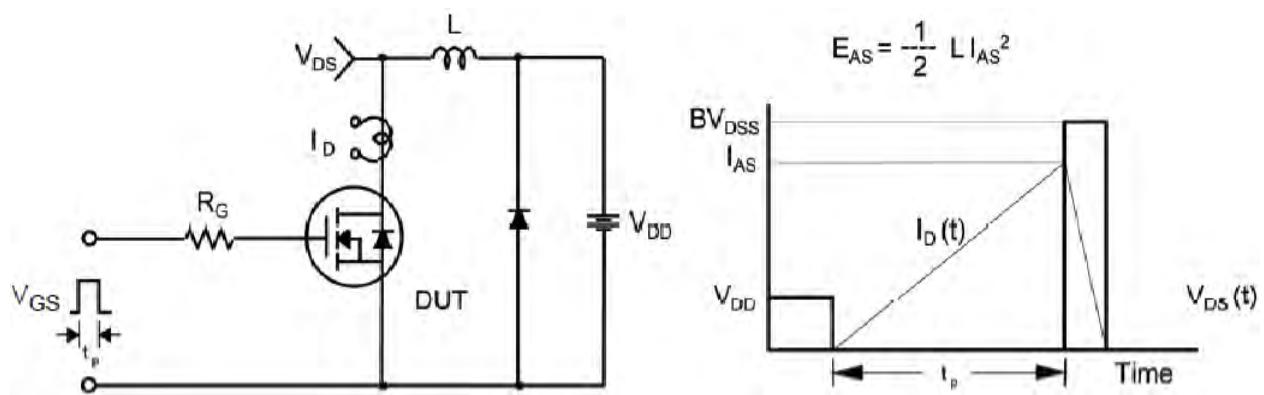
## Gate Charge Test Circuit & Waveform



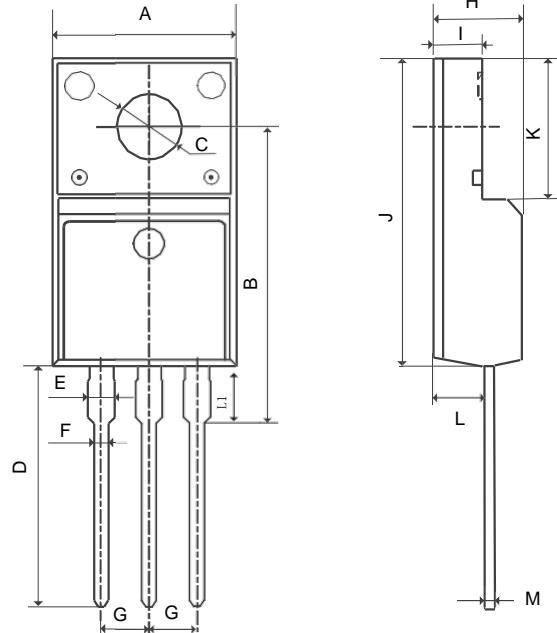
## Switching Test Circuit & Waveforms



## Unclamped Inductive Switching Test Circuit & Waveforms



## Mechanical Dimensions for TO-220F



## COMMON DIMENSIONS

SYMBOL	MM	
	MIN	MAX
A	9.96	10.36
B	15.10	16.10
C	3.03	3.38
D	12.64	13.28
E	1.18	1.58
F	0.70	0.95
G	2.54REF	
H	4.50	4.90
I	2.34	2.74
J	15.57	16.17
K	6.70REF	
L	2.56	2.96
M	0.40	0.65
L1	2.85	3.45